

## -5A,-15V P-Channel Power MOSFET

### GENERAL DESCRIPTION

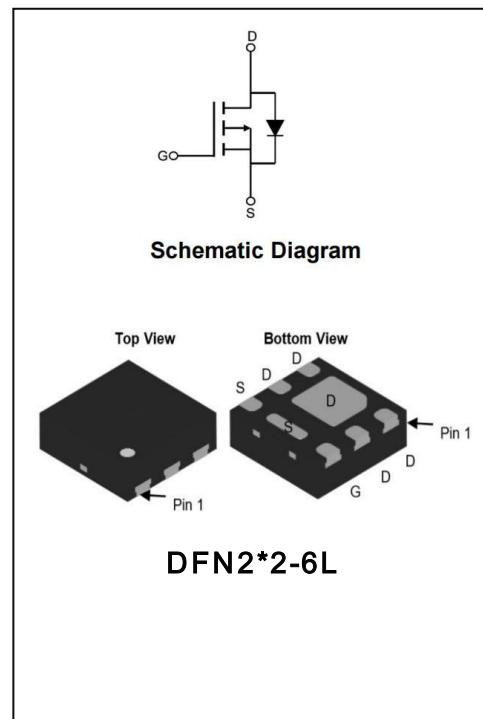
The Power MOSFET has extremely low on resistance, making it especially suitable for applications which require superior power density and outstanding efficiency.

### Features

- ◆  $V_{DS} = -15V$ ,  $I_D = -5A$
- ◆  $R_{DS(ON)}$   
TYP:  $19m\Omega @ V_{GS} = -4.5V$
- ◆  $TYP: 28m\Omega @ V_{GS} = -2.5V$

### Applications

- ◆ Load Switch
- ◆ PWM Applications
- ◆ Power Management



### ORDERING INFORMATION

Part No.	Package	Marking	Material	Packing
SFR01505PT	DFN2*2	01505PT	Pb Free	Reel

**ABSOLUTE MAXIMUM RATINGS (T<sub>J</sub>=25°C unless otherwise noted)**

Characteristics	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	-15	V
Gate-Source Voltage	V <sub>GS</sub>	±12	V
Drain Current	I <sub>D</sub>	-5	A
T <sub>C</sub> = 75°C	I <sub>D</sub>	-3.9	
Drain Current Pulsed(Note 1)	I <sub>DM</sub>	-20	A
Power Dissipation(T <sub>C</sub> =25°C) -Derate above 25°C	P <sub>D</sub>	8.8	W
Single Pulsed Avalanche Energy (Note 2)	E <sub>AS</sub>	12	mJ
Operation Junction Temperature Range	T <sub>J</sub>	-55~+150	°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	TL	300	°C

**ELECTRICAL CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
Drain -Source Breakdown Voltage	B <sub>VDSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-15	--	--	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V	--	--	1	uA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = 12V, V <sub>DS</sub> = 0V	--	--	100	nA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = -12V, V <sub>DS</sub> = 0V	--	--	-100	
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250μA	-0.4	-0.65	-1.0	V
Static Drain- Source On State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2.5A	--	19	25	mΩ
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -1.5A	--	28	38	
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -10V V <sub>GS</sub> = 0V f=1.0MHZ	--	633	--	pF
Output Capacitance	C <sub>oss</sub>		--	86	--	
Reverse Transfer Capacitance	C <sub>rss</sub>		--	61	--	
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = -10V, V <sub>GS</sub> = -4.5V R <sub>G</sub> = 1 Ω , I <sub>D</sub> = -3.0A (Note 3.4)	--	11.3	--	nS
Turn-on Rise Time	t <sub>r</sub>		--	29	--	
Turn-off Delay Time	t <sub>d(off)</sub>		--	48	--	
Turn-off Fall Time	t <sub>f</sub>		--	51	--	
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =-10V, I <sub>D</sub> =-3.0A V <sub>GS</sub> =-4.5V (Note 3.4)	--	9.1	--	nC
Gate-Source Charge	Q <sub>gs</sub>		--	1.5	--	
Gate-Drain Charge	Q <sub>gd</sub>		--	1.9	--	

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

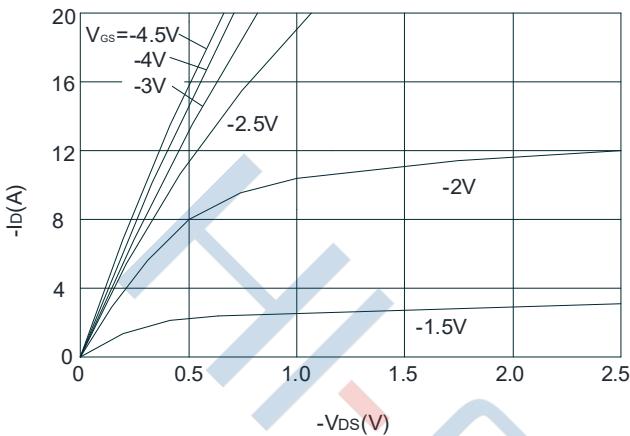
Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	-5	A
Pulsed Source Current	$I_{SM}$		--	--	-20	
Diode Forward Voltage	$V_{SD}$	$I_S = -5A, V_{GS} = 0V$	--	-0.86	-1.2	V

## NOTE:

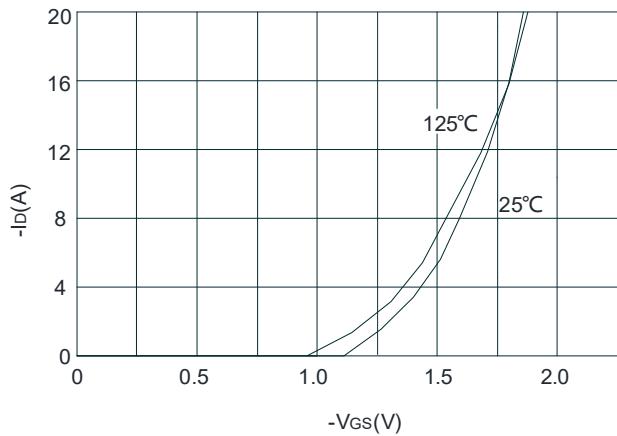
- 1.Pulse width limited by maximum junction temperature
2. $L=0.5mH$ ,  $V_{DD}=-10V$ ,  $V_G=-10V$ ,  $R_G=25\Omega$ , starting  $T_J=25^\circ C$
- 3.Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle $\leq 2\%$
- 4.Essentially independent of operating temperature

## Typical Performance Characteristics

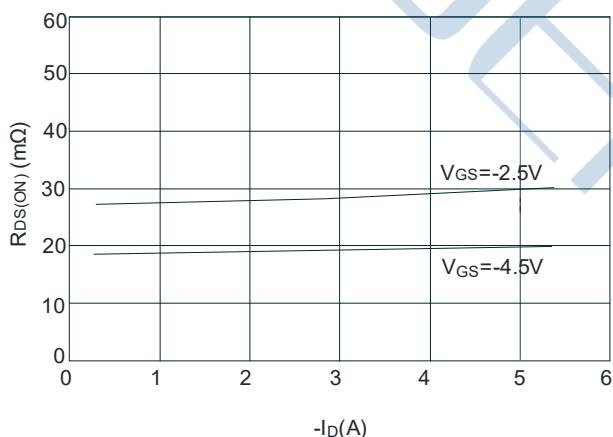
**Figure 1:** Output Characteristics



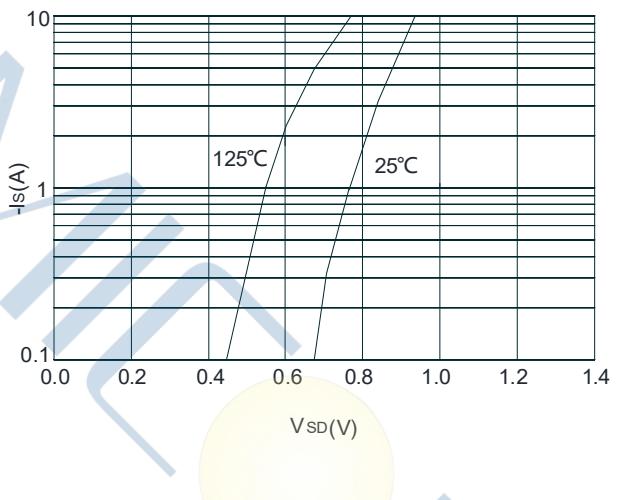
**Figure 2:** Typical Transfer Characteristics



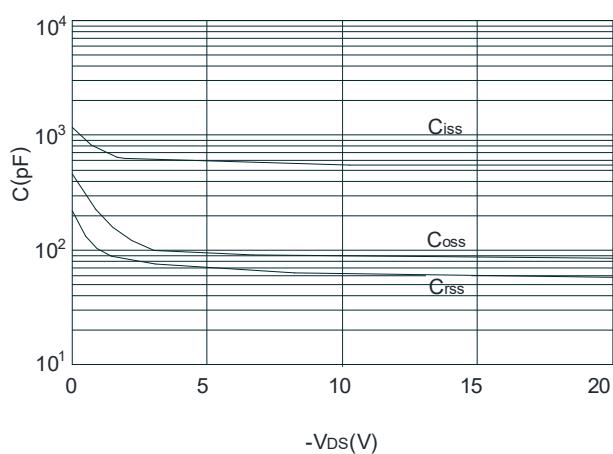
**Figure 3:** On-resistance vs. Drain Current



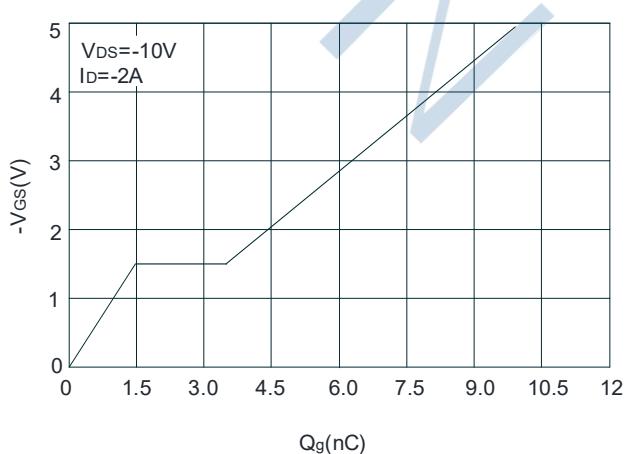
**Figure 4:** Body Diode Characteristics



**Figure 5 :** Capacitance Characteristics

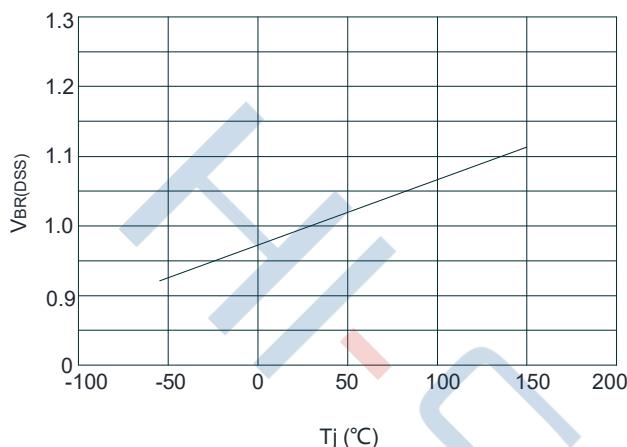


**Figure 6 :** Gate Charge Characteristics

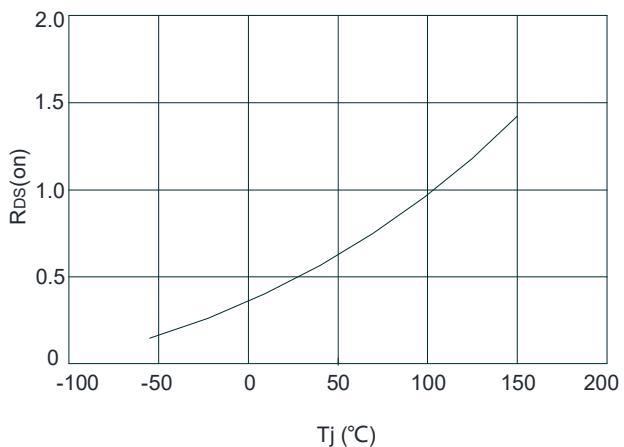


## Typical Performance Characteristics

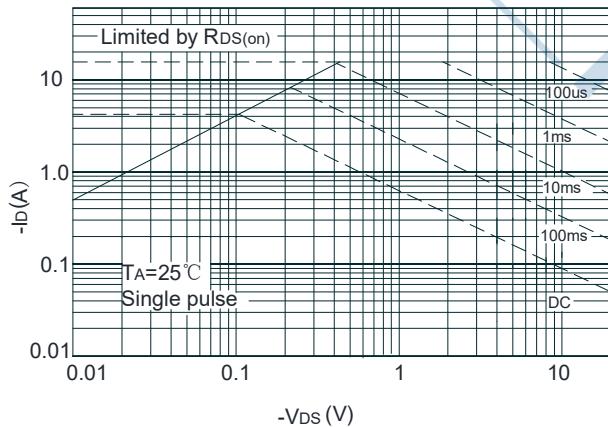
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



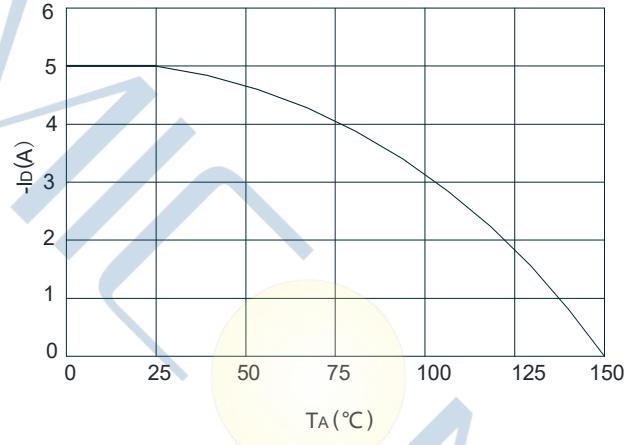
**Figure 8:** Normalized on Resistance vs. Junction Temperature



**Figure 9:** Maximum Safe Operating Area

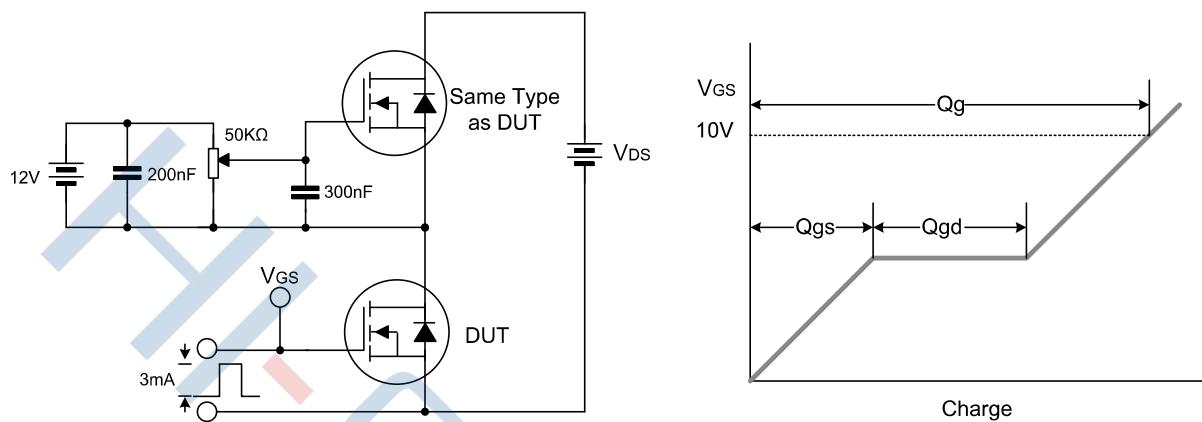


**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature

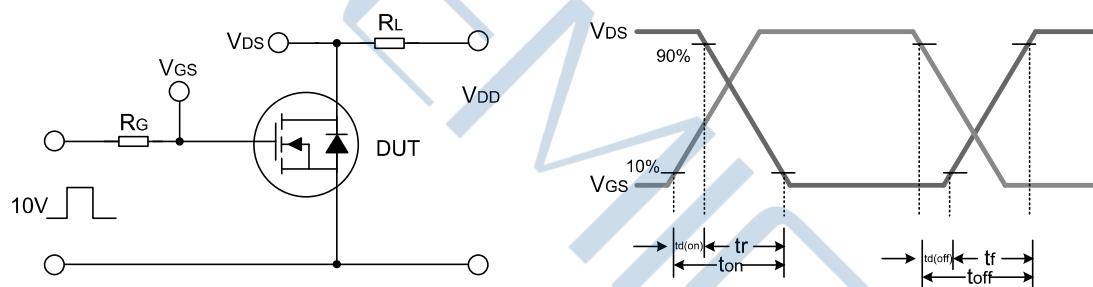


## Test Circuit

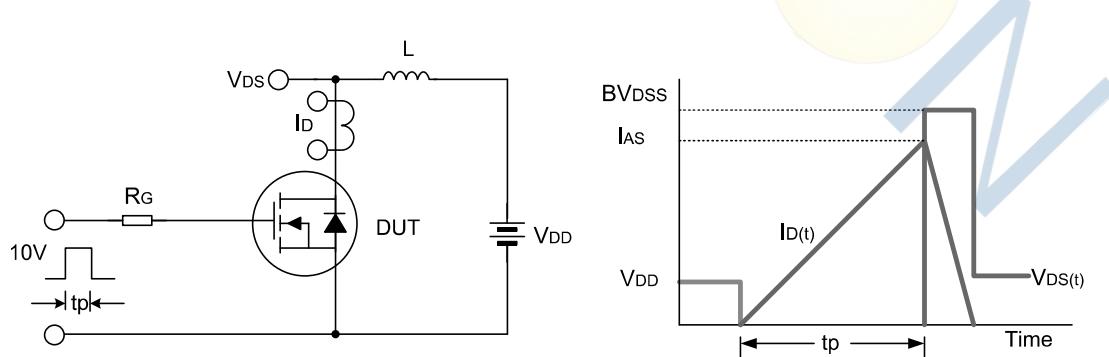
Gate Charge Test Circuit &amp; Waveform



Resistive Switching Test Circuit &amp; Waveform

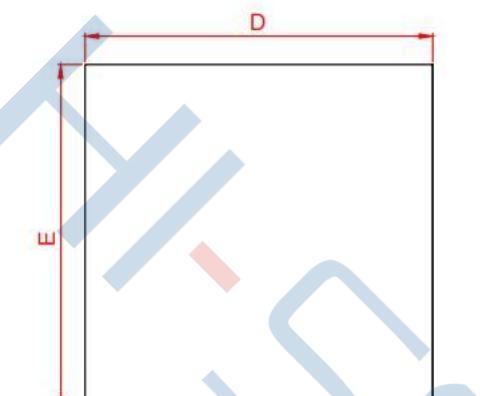


Unclamped Inductive Switching Test Circuit &amp; Waveform

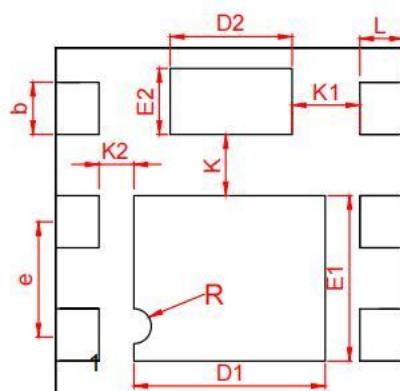


## Package Dimensions of DFN2\*2

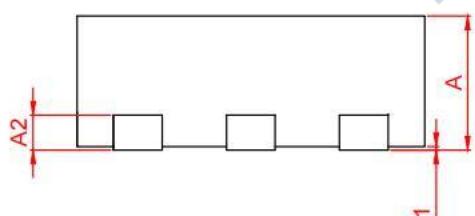
Unit:mm



TOP VIEW



BOTTOM VIEW



SIDE VIEW

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.70	0.75	0.80
*A1	0.00	0.02	0.05
*b	0.25	0.30	0.35
*A2	0.203 BSC		
*D	1.90	2.00	2.10
*E	1.90	2.00	2.10
*E1	0.90	0.95	1.00
*E2	0.33	0.38	0.43
*D1	1.10	1.15	1.20
*D2	0.65	0.70	0.75
*e	0.65 REF		
*L	0.22	0.25	0.27
*K	0.30	0.35	0.40
*K1	0.35	0.40	0.45
*K2	0.18	0.20	0.22

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